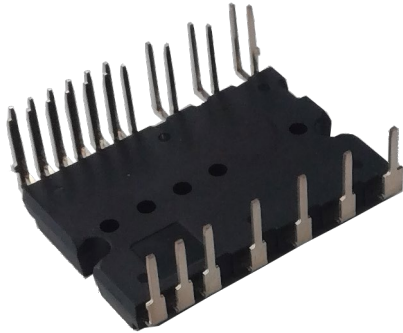


< DIIPM >

PSS30SF1F6

TRANSFER MOLDING TYPE
INSULATED TYPE

OUTLINE



MAIN FUNCTION AND RATINGS

- Inverter bridge for three phase DC-to-AC power conversion
- 600V / 30A
- TRANSFER MOLDING TYPE
- Open emitter type
- Built-in bootstrap diodes with current limiting resistor

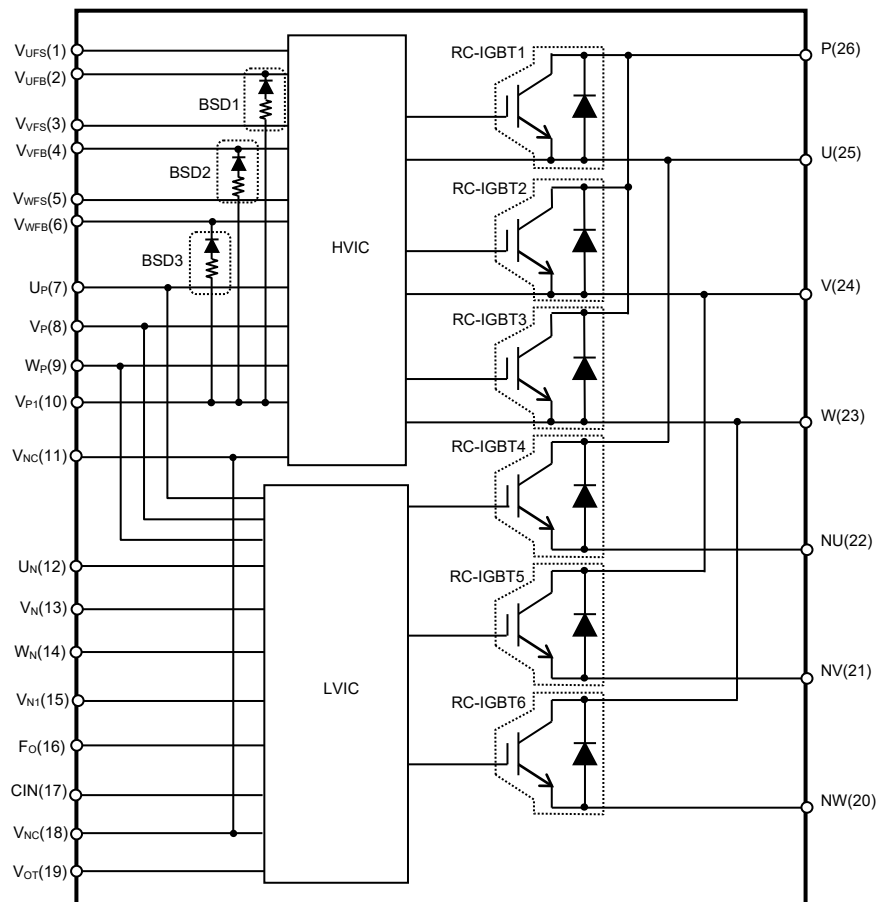
APPLICATION

- AC 100~240Vrms(DC voltage:400V or below) class low power motor control

INTEGRATED DRIVE, PROTECTION AND SYSTEM CONTROL FUNCTIONS

- For P-side : Drive circuit, High voltage high-speed level shifting, Control supply under-voltage protection (UV)
- For N-side : Drive circuit, Control supply under-voltage protection (UV), Short circuit protection (SC)
- Fault signaling : Corresponding to SC fault (N-side RC-IGBT) and UV fault (N-side supply)
- Temperature output : Outputting LVIC temperature by analog signal
- Input interface : 3, 5V line, Schmitt trigger receiver circuit (High Active)
- UL Recognized : UL1557 File E323585

INTERNAL CIRCUIT



MAXIMUM RATINGS ($T_j = 25^\circ\text{C}$, unless otherwise noted)**INVERTER PART**

Symbol	Parameter	Condition	Ratings	Unit
V_{CC}	Supply voltage	Applied between P-NU,NV,NW	450	V
$V_{CC(\text{surge})}$	Supply voltage (surge)	Applied between P-NU,NV,NW	500	V
V_{CES}	Collector-emitter voltage		600	V
$\pm I_C$	Each IGBT collector current	$T_C = 25^\circ\text{C}$ (Note 1)	30	A
$\pm I_{CP}$	Each IGBT collector current (peak)	$T_C = 25^\circ\text{C}$, less than 1ms, non-repetitive	60	A
T_{jop}	Junction temperature	Continuous operation (Note 2)	-40~+150	$^\circ\text{C}$
T_{jmax}	Junction temperature	Temporally operation (e.g. overload)	175	$^\circ\text{C}$

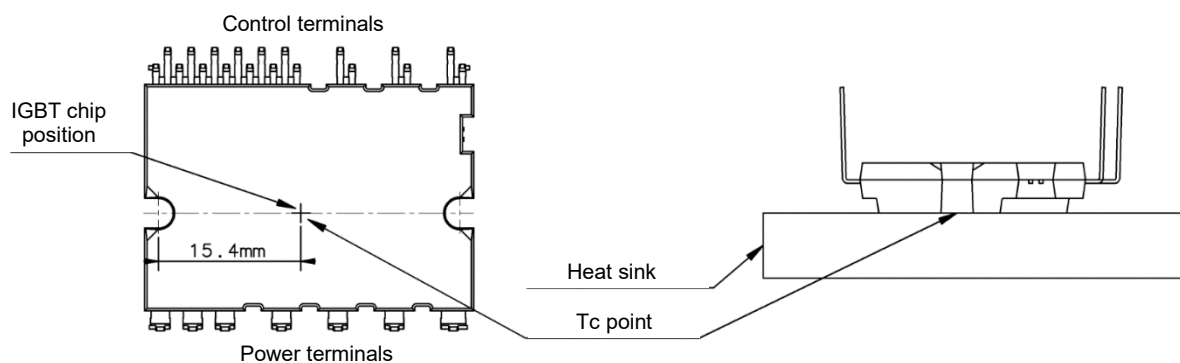
(Note1) Pulse width and period are limited due to junction temperature.

(Note2) The maximum junction temperature rating of built-in power chips is 175°C ($@T_C \leq 125^\circ\text{C}$). However, to ensure safe operation of DIIPM, the average junction temperature should be limited to $T_j \leq 150^\circ\text{C}$ ($@T_C \leq 125^\circ\text{C}$).**CONTROL (PROTECTION) PART**

Symbol	Parameter	Condition	Ratings	Unit
V_D	Control supply voltage	Applied between	20	V
V_{DB}	Control supply voltage	Applied between	20	V
V_{IN}	Input voltage	Applied between	$-0.5 \sim V_D + 0.5$	V
V_{FO}	Fault output supply voltage	Applied between	$-0.5 \sim V_D + 0.5$	V
I_{FO}	Fault output current	Sink current at F_O terminal	5	mA
V_{SC}	Current sensing input voltage	Applied between $CIN-V_{NC}$	$-0.5 \sim V_D + 0.5$	V

TOTAL SYSTEM

Symbol	Parameter	Condition	Ratings	Unit
$V_{CC(\text{PROT})}$	Self protection supply voltage limit (Short circuit protection capability)	$V_D = 13.5 \sim 16.5\text{V}$, Inverter Part $T_j = 150^\circ\text{C}$, less than $2\mu\text{s}$, non-repetitive	400	V
T_C	Module case operation temperature	Measurement point of T_C is described in Fig.1	-40~+125	$^\circ\text{C}$
T_{stg}	Storage temperature		-40~+125	$^\circ\text{C}$
V_{iso}	Isolation voltage	60Hz, Sinusoidal, AC 1min, between connected all pins and heat sink plate	2500	Vrms

Fig. 1 T_C MEASUREMENT POINT**THERMAL RESISTANCE**

Symbol	Parameter	Condition	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Junction to case thermal resistance (Note 3)	Inverter RC-IGBT part (per 1/6 module)	-	-	1.05	K/W

Note 3: Grease with good thermal conductivity and long-term endurance should be applied evenly with about $+100\mu\text{m} \sim +200\mu\text{m}$ on the contacting surface of DIIPM and heat sink. The contacting thermal resistance between DIIPM case and heat sink $R_{th(c-f)}$ is determined by the thickness and the thermal conductivity of the applied grease. For reference, $R_{th(c-f)}$ is about 0.4K/W (per 1/6 module, grease thickness: $20\mu\text{m}$, thermal conductivity: $1.0\text{W/m}\cdot\text{K}$).

ELECTRICAL CHARACTERISTICS ($T_{ch} = 25^{\circ}\text{C}$, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Condition	Limits			Unit
			Min.	Typ.	Max.	
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_D = V_{DB} = 15\text{V}$, $V_{IN} = 5\text{V}$, $I_C = 30\text{A}$	-	1.27	1.57	V
V_{EC}	FWDi forward voltage	$V_{IN} = 0\text{V}$, $-I_C = 30\text{A}$	-	1.35	1.64	V
t_{on}	Switching times	$V_{CC} = 300\text{V}$, $V_D = V_{DB} = 15\text{V}$ $I_C = 30\text{A}$, $T_J = 25^{\circ}\text{C}$, $V_{IN} = 0 \leftrightarrow 5\text{V}$ Inductive Load (upper-lower arm)	0.57	1.00	1.45	μs
t_{tr}			-	0.19	-	μs
$t_{c(on)}$			-	0.29	0.54	μs
t_{off}			-	1.20	1.64	μs
$t_{c(off)}$			-	0.16	0.37	μs
I_{CES}	Collector-emitter cut-off current	$V_{CE} = V_{CES}$	-	-	1	mA

CONTROL (PROTECTION) PART

Symbol	Parameter	Condition	Limits			Unit
			Min.	Typ.	Max.	
I_D	Circuit current	Total of $V_{P1}-V_{NC}$, $V_{N1}-V_{NC}$	$V_D=15\text{V}$, $V_{IN}=0\text{V}$	-	-	4.00
			$V_D=15\text{V}$, $V_{IN}=5\text{V}$	-	-	4.00
I_{DB}		Each part of $V_{UFB}-V_{UFS}$, $V_{VFB}-V_{VFS}$, $V_{WFB}-V_{WFS}$	$V_D=V_{DB}=15\text{V}$, $V_{IN}=0\text{V}$	-	-	0.55
			$V_D=V_{DB}=15\text{V}$, $V_{IN}=5\text{V}$	-	-	0.55
$V_{SC(ref)}$	Short circuit trip level	$V_D = 15\text{V}$ (Note 4)	0.455	0.480	0.505	V
UV_{DBt}	P-side Control supply under-voltage protection(UV)	Trip level	10.2	-	12.9	V
UV_{DBr}		Reset level	10.2	-	12.9	V
UV_{Dt}	N-side Control supply under-voltage protection(UV)	Trip level	10.3	-	12.5	V
UV_{Dr}		Reset level	10.8	-	13.0	V
V_{OT}	Temperature Output	Pull down $R=5.1\text{k}\Omega$ (Note 5) LVIC Temperature= 90°C	2.63	2.80	2.97	V
V_{FOH}	Fault output voltage	$V_{SC} = 0\text{V}$, F_O terminal pulled up to 5V by 10k Ω	4.9	-	-	V
V_{FOL}		$V_{SC} = 1\text{V}$, $I_{FO} = 1\text{mA}$	-	-	0.95	V
t_{FO}	Fault output pulse width	(Note 6)	200	-	-	μs
I_{IN}	Input current	$V_{IN} = 5\text{V}$	0.70	1.00	1.50	mA
$V_{th(on)}$	ON threshold voltage	Applied between U_P , V_P , W_P , U_N , V_N , W_N-V_{NC}	-	2.20	2.60	V
$V_{th(off)}$	OFF threshold voltage		0.80	1.40	-	V
$V_{th(hys)}$	ON/OFF threshold hysteresis voltage		0.35	0.80	-	
V_F	Bootstrap Di forward voltage	$I_F=10\text{mA}$ including voltage drop by limiting resistor (Note 7)	0.5	0.9	1.3	V
R	Built-in limiting resistance	$I_F=300\text{mA}$	16	20	24	Ω

Note 4: SC protection works only for N-side IGBT. Please select the external shunt resistance such that the SC trip-level is less than I_{cp} .

5 : For temperature output type, DIIPM don't shutdown IGBTs and output fault signal automatically when temperature rises excessively. When temperature exceeds the protective level that user defined, controller (MCU) should stop the DIIPM. Temperature of LVIC vs. VOT output characteristics is described in Fig. 3.

6 : Fault signal F_O outputs when SC or UV protection works. F_O pulse width is different for each protection modes. At SC failure, F_O pulse width is a fixed width (=minimum 200 μs), but at UV failure, F_O outputs continuously until recovering from UV state. (But minimum F_O pulse width is 200 μs .)

7 : The characteristics of bootstrap Di is described in Fig.2.

Fig. 2 Characteristics of Bootstrap Di V_F - I_F curve (@ $T_a=25^{\circ}\text{C}$) Including Voltage Drop by Limiting Resistor (Right chart is enlarged chart.)

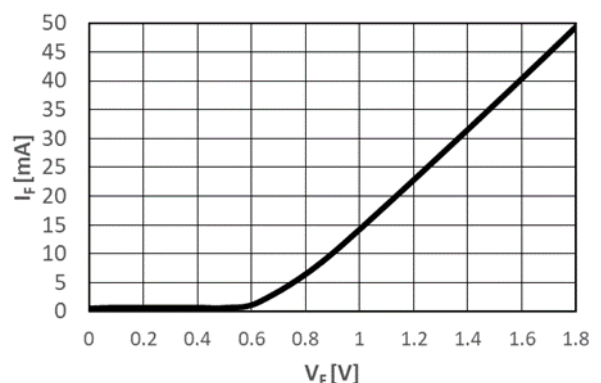
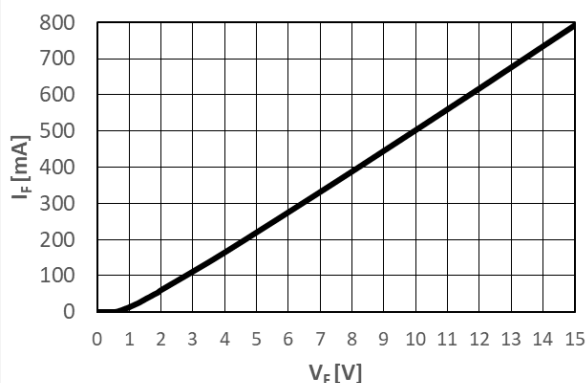


Fig. 3 Temperature of LVIC vs. VOT Output Characteristics

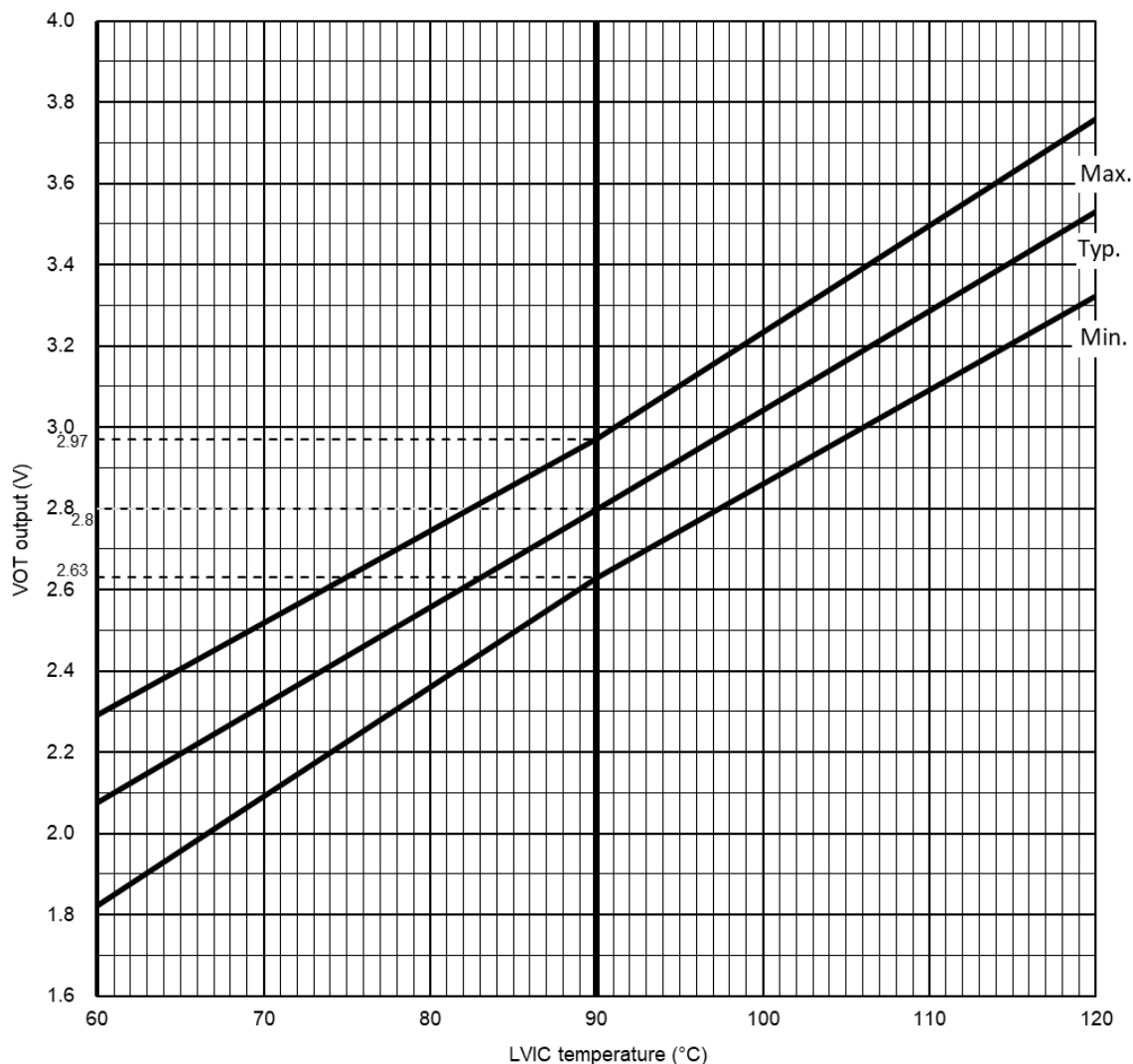
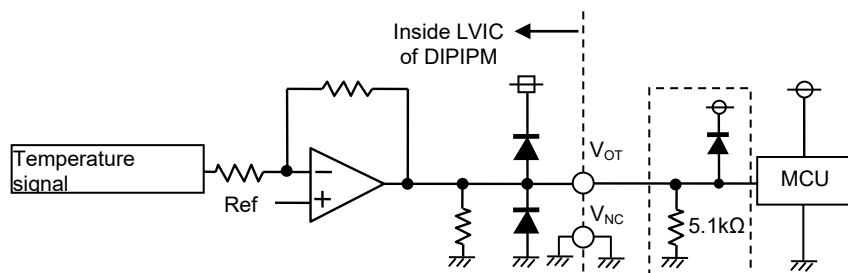


Fig. 4 VOT output circuit

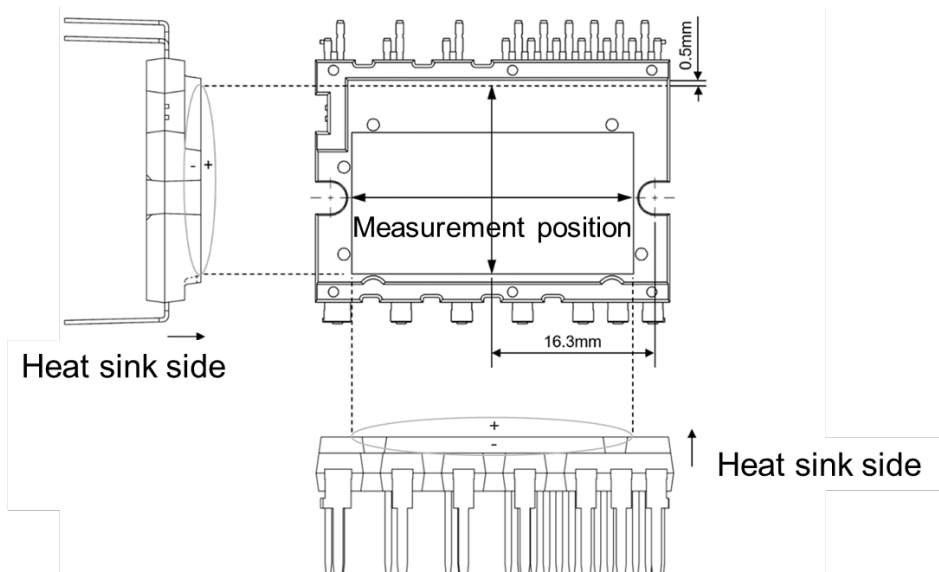


- (1) It is recommended to insert 5kΩ (5.1kΩ is recommended) pull down resistor for getting linear output characteristics at low temperature below room temperature. When the pull down resistor is inserted between V_{OT} and V_{NC} (control GND), the extra circuit current, which is calculated approximately by V_{OT} output voltage divided by pull down resistance, flows as LVIC circuit current continuously. In the case of using V_{OT} for detecting high temperature over room temperature only, it is unnecessary to insert the pull down resistor.
- (2) In the case of using V_{OT} with low voltage controller like 3.3V MCU, V_{OT} output might exceed control supply voltage 3.3V when temperature rises excessively. If system uses low voltage controller, it is recommended to insert a clamp Di between control supply of the controller and V_{OT} output for preventing over voltage destruction.
- (3) In the case of not using V_{OT} , leave V_{OT} output NC (No Connection).
Refer the application note about the usage of V_{OT} .

Parameter	Condition	Reference	Limits			Unit
			Min.	Typ.	Max.	
Mounting torque	Mounting screw : M3 (Note 8)	JEITA-ED-4701 402 method II	0.59	0.69	0.78	N·m
Terminal pulling strength	Control terminal: Load 2.3N Power terminal: Load 2.3N	JEITA-ED-4701 401 method I	30	-	-	s
Terminal bending strength	15deg. Bend	JEITA-ED-4701 401 method III	1	-	-	times
Weight		-	-	10.3	-	g
Heat radiation part flatness	(Note 9)	-	-30	-	+100	μm

Note 8: Plain washers (JIS B1256) are recommended.

Note 9: Measurement point of heat radiation part flatness



RECOMMENDED OPERATION CONDITIONS

Symbol	Parameter	Condition	Limits			Unit
			Min.	Typ.	Max.	
V_{CC}	Supply voltage	P-NU, NV, NW 端子間	0	300	400	V
V_D	Control supply voltage	$V_{P1}-V_{NC}$, $V_{N1}-V_{NC}$ 端子間	13.5	15.0	16.5	V
V_{DB}	Control supply voltage	$V_{UFB}-V_{UFS}$, $V_{VFB}-V_{VFS}$, $V_{WFB}-V_{WFS}$ 端子間	13.0	15.0	18.5	V
$\Delta V_D, \Delta V_{DB}$	Control supply variation		-1	-	+1	V/μs
t_{dead}	Arm shoot-through blocking time	For each input signal	1.5	-	-	μs
f_{PWM}	PWM input frequency	$T_C \leq 125^\circ\text{C}$, $T_J \leq 150^\circ\text{C}$	-	-	20	kHz
PWIN(on)	Minimum input pulse width	(Note10)	0.7	-	-	μs
PWIN(off)		(Note11)	1.5	-	-	
V_{NC}	V_{NC} variation	Between $V_{NC}-NU$, NV, NW (including surge)	-5.0	-	+5.0	V

Note10: DIIPM might not make response if the input signal pulse width is less than PWIN(on).

Note11: DIIPM might make no response or delayed response (P-side IGBT only) for input pulse width less than PWIN(off). Over rated collector current (I_c) operation, DIIPM might make delayed response even if the input signal pulse width is PWIN(off) or more. The timing charts are described as below.

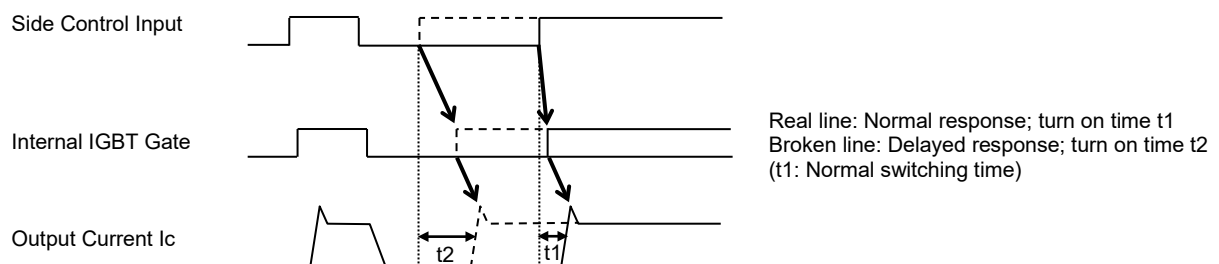
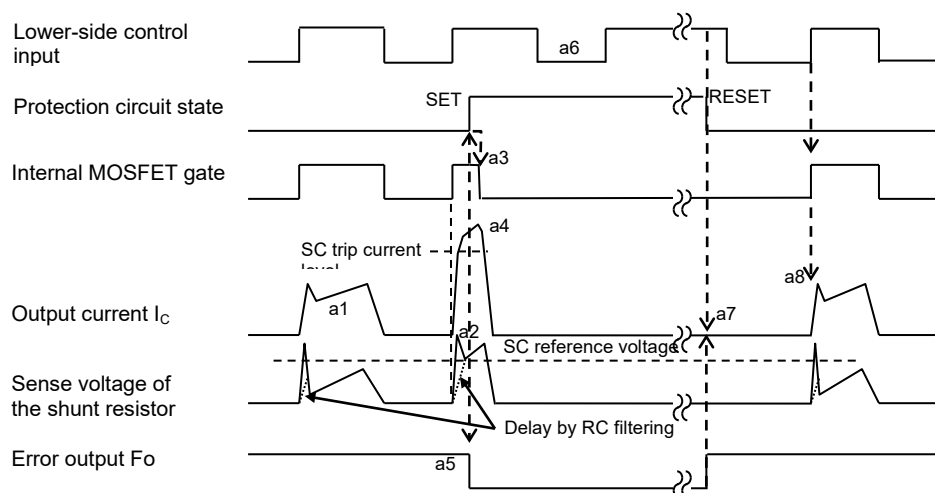


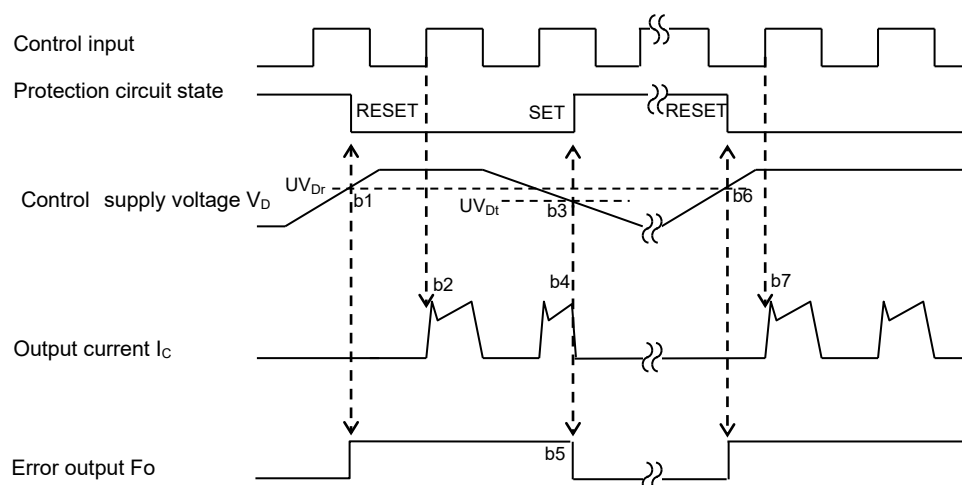
Fig. 5 Timing Charts of The DIIPM Protective Functions

[A] Short-Circuit Protection (N-side only with the external shunt resistor and RC filter)

- a1. Normal operation: MOSFET ON and outputs current.
- a2. Short circuit current detection (SC trigger)
(It is recommended to set RC time constant $1.5 \sim 2.0 \mu\text{s}$ so that MOSFET shut down within $2.0 \mu\text{s}$ when SC.)
- a3. All N-side MOSFETs gates are hard interrupted.
- a4. All N-side MOSFETs turn OFF.
- a5. F_o outputs for t_{Fo} =minimum $200 \mu\text{s}$.
- a6. Input = "L": MOSFET OFF
- a7. F_o finishes output, but MOSFETs don't turn on until inputting next ON signal (L→H).
(MOSFETs of each phase can return to normal state by inputting ON signal to each phase.)
- a8. Normal operation: MOSFET ON and outputs current.

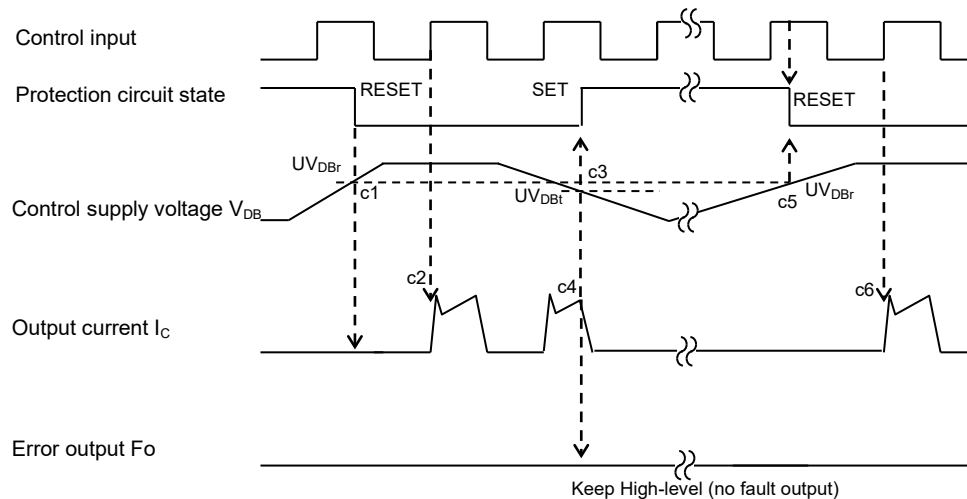
[B] Under-Voltage Protection (N-side, UV_D)

- b1. Control supply voltage V_D exceeds under voltage reset level (UV_{Dr}), but MOSFET turns ON by next ON signal (L→H).
(MOSFET of each phase can return to normal state by inputting ON signal to each phase.)
- b2. Normal operation: MOSFET ON and outputs current.
- b3. V_D level drops to under voltage trip level. (UV_{Dt}).
- b4. All N-side MOSFETs turn OFF in spite of control input condition.
- b5. F_o outputs for t_{Fo} =minimum $200 \mu\text{s}$, but output is extended during V_D keeps below UV_{Dr} .
- b6. V_D level reaches UV_{Dr} .
- b7. Normal operation: MOSFET ON and outputs current.



[C] Under-Voltage Protection (P-side, UV_{DB})

- c1. Control supply voltage V_{DB} rises. After the voltage reaches under voltage reset level UV_{DBr} , MOSFET turns on by next ON signal (L→H).
 c2. Normal operation: MOSFET ON and outputs current.
 c3. V_{DB} level drops to under voltage trip level (UV_{DBt}).
 c4. MOSFET of the corresponding phase only turns OFF in spite of control input signal level, but there is no F_O signal output.
 c5. V_{DB} level reaches UV_{DBr} .
 c6. Normal operation: MOSFET ON and outputs current.



[D] Interlock Sequence

- d1. When N-side is ON state(H), P-side turn ON(L→H) N-side shut off(Note12)
 d2. When P-side is ON state(H), N-side turn ON(L→H) N-side shut off
 d3. P-side turn OFF(H→L) and N-side is ON state(H) N-side turn ON(Note12)
 (Note12) When d1 and d3 are active, a small-time-period through current may flow due to the difference in transmission delay between the control inputs on the P-side and N-side and the internal IGBT gate signal.

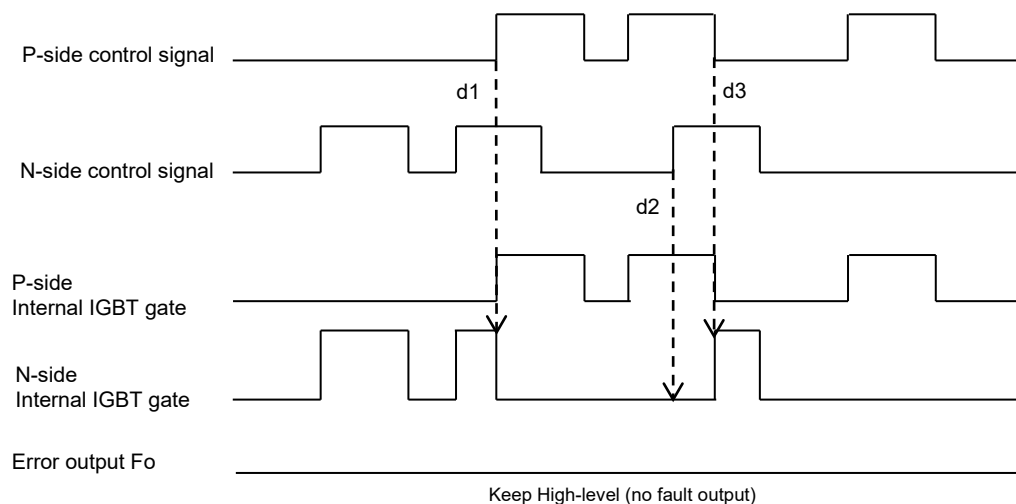
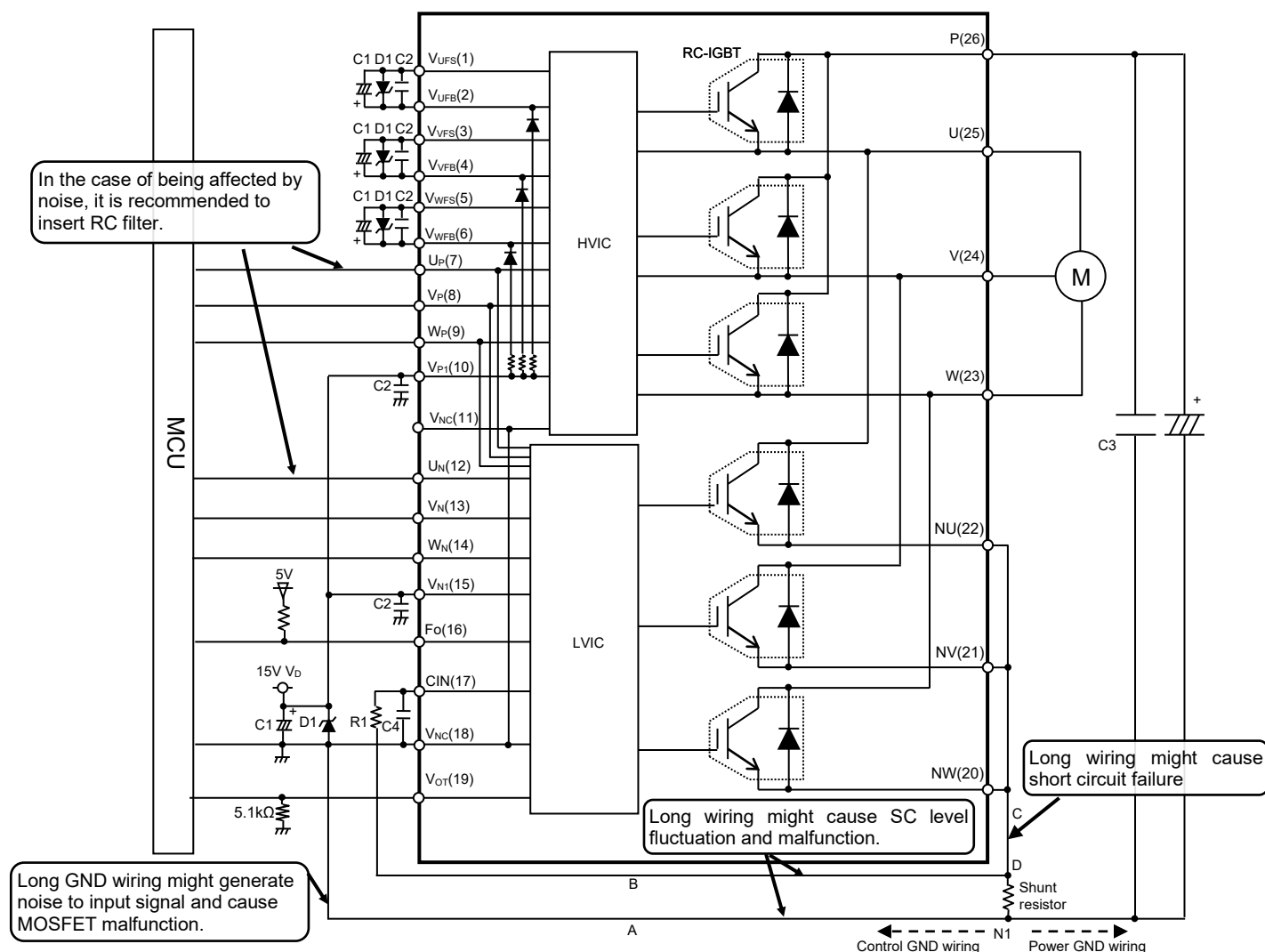
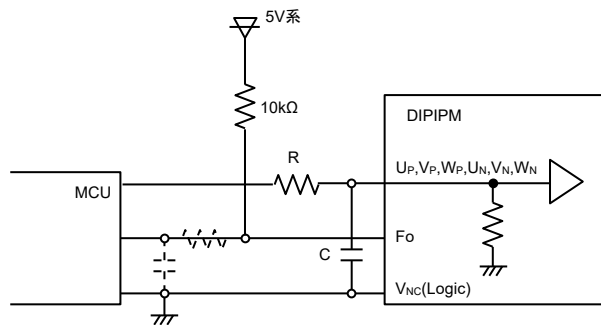


Fig. 6 Example of Application Circuit



- (1) If control GND is connected with power GND by common broad pattern, it may cause malfunction by power GND fluctuation. It is recommended to connect control GND and power GND at only a point N1 (near the terminal of shunt resistor).
- (2) It is recommended to insert a Zener diode D1(24V/1W) between each pair of control supply terminals to prevent surge destruction.
- (3) To prevent surge destruction, the wiring between the smoothing capacitor and the P, N1 terminals should be as short as possible. Generally a snubber capacitor C3 (more than 0.1μF) between the P-N1 terminals is recommended. C3 capacitor value should be selected by enough system evaluation.
- (4) R1, C4 of RC filter for preventing protection circuit malfunction is recommended to select tight tolerance, temp-compensated type. The time constant R1C4 should be set so that SC current is shut down within 2μs. (1.5μs~2μs is general value.) SC interrupting time might vary with the wiring pattern, so the enough evaluation on the real system is necessary.
- (5) To prevent malfunction, the wiring of A, B, C should be as short as possible.
- (6) The point D at which the wiring to CIN filter is divided should be near the terminal of shunt resistor. NU, NV, NW terminals should be connected at near NU, NV, NW terminals.
- (7) All capacitors should be mounted as close to the terminals as possible. (C1: good temperature, frequency characteristic electrolytic type and C2: 0.22μ~2μF, good temperature, frequency and DC bias characteristic ceramic type are recommended.)
- (8) Input drive is High-active type. There is a minimum 3.3kΩ pull-down resistor in the input circuit of IC. To prevent malfunction, the wiring of each input should be as short as possible. When using RC coupling circuit, make sure the input signal level meet the turn-on and turn-off threshold voltage.
- (9) Thanks to built-in HVIC, direct coupling to MCU without any optocoupler or transformer isolation is possible.
- (10) Fo output is open drain type. It should be pulled up to MCU or control power supply (e.g. 5V, 15V) by a resistor that makes I_{Fo} up to 1mA. (I_{Fo} is estimated roughly by the formula of control power supply voltage divided by pull-up resistance. In the case of pulled up to 5V, 10kΩ (5kΩ or more) is recommended.)
- (11) Two VNC terminals are connected inside DIPIPM, please connect either one to the 15V power supply GND outside and leave another one open.
- (12) If high frequency noise superimposed to the control supply line, IC malfunction might happen and cause DIPIPM erroneous operation. To avoid such problem, line ripple voltage should meet $dV/dt \leq \pm 1V/\mu s$, $V_{ripple} \leq 2V_{p-p}$.
- (13) For DIPIPM, it isn't recommended to drive same load by parallel connection with other phase MOSFET or other DIPIPM.

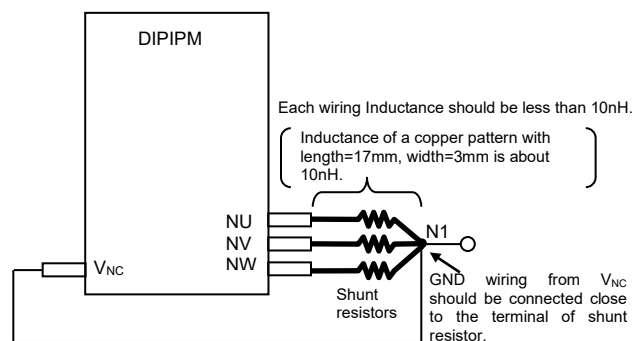
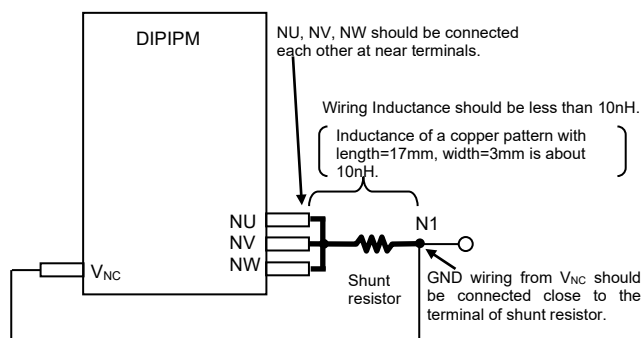
Fig. 7 MCU I/O Interface Circuit



Note: The RC coupling (parts shown in the dotted line) at each input depends on user's PWM control strategy and the wiring impedance of the printed circuit board.

The DIIPM signal input section integrates a 3.3kΩ(min) pull-down resistor. Therefore, when using an external filtering resistor, please pay attention to the signal voltage drop at input terminal.

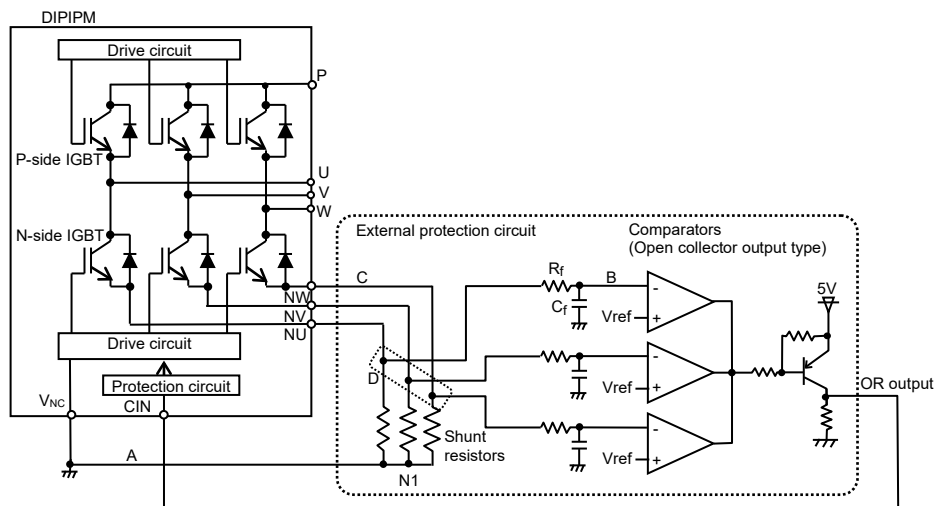
Fig. 8 Pattern Wiring Around the Shunt Resistor



Low inductance shunt resistor like surface mounted (SMD) type is recommended.

Fig. 9 External SC Protection Circuit with Using Three Shunt Resistors

When DIIPM is operated with three shunt resistors, voltage of each shunt resistor cannot be input to CIN terminal directly. In that case, it is necessary to use the external protection circuit as below.



- (1) It is necessary to set the time constant $R_f C_f$ of external comparator input so that MOSFET stop within $2\mu s$ when short circuit occurs. SC interrupting time might vary with the wiring pattern, comparator speed and so on.
- (2) The threshold voltage V_{ref} should be set up the same rating of short circuit trip level ($V_{sc(ref)}$ typ. 0.48V).
- (3) Select the external shunt resistance so that SC trip-level is less than specified maximum value.
- (4) To avoid malfunction, the wiring A, B, C should be as short as possible.
- (5) The point D at which the wiring to comparator is divided should be near the terminal of shunt resistor.
- (6) OR output high level should be over 0.505V (=maximum $V_{sc(ref)}$).
- (7) GND of Comparator, V_{ref} circuit and C_f should be not connected to noisy power GND but to control GND wiring.

Fig. 10 Package Outlines

[Dimension: mm]

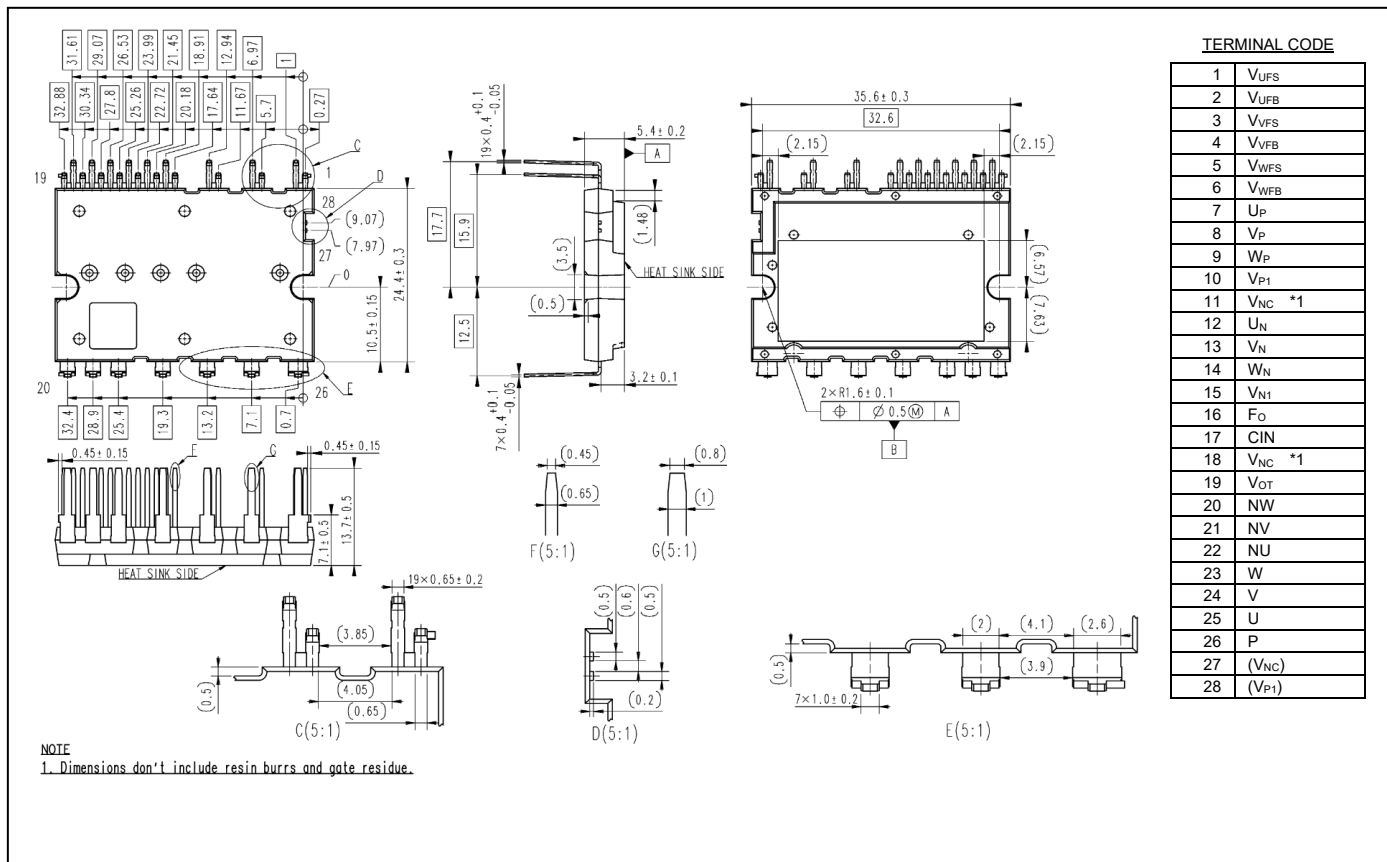
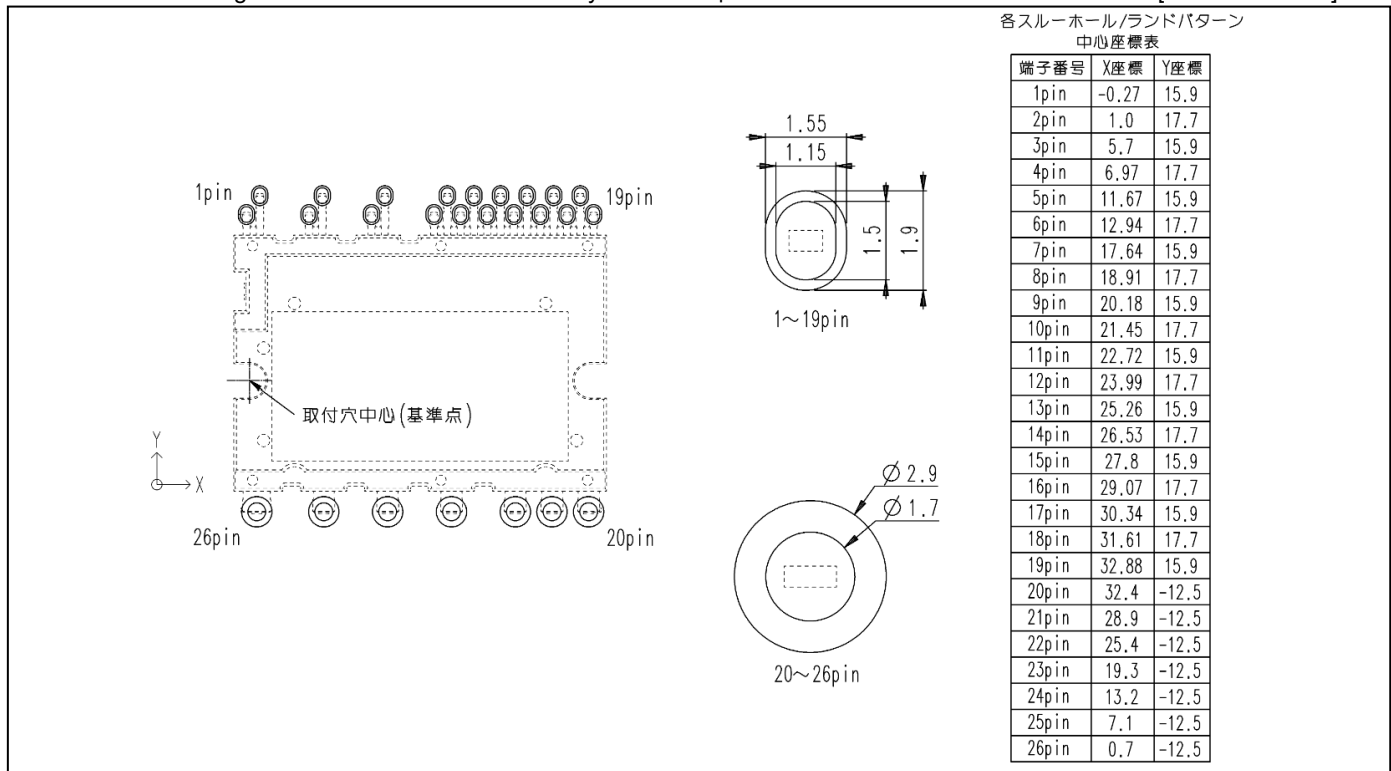


Fig. 11 (Reference Figure) PCB Through-hole Pattern

Recommended through-hole locations and diameter layout for Compact DIPIPM

[Dimension: mm]



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